

**Amendments to the Claims:**

This listing of claims will replace all prior versions, and listings, of claims in the application.

**Listing of Claims:**

1. (Currently Amended) A power supply device comprising:

a capacitor unit in which capacitors are interconnected in series or in series-parallel;

a charging unit for charging the capacitor unit at a constant current;

a detecting unit for detecting voltage on a high potential side of each capacitor;

a determining unit for determining existence of an abnormality by performing calculation based on the voltage detected by the detecting unit; and

a communication unit for outputting a determining result from the determining unit,

wherein

the determining unit determines the abnormality when difference between respective voltages on the high potential side of some adjacent capacitors exceeds upper-limit voltage "Va", when the difference is lower than lower-limit voltage "Vb", or when a voltage value is negative, and

the determination is ~~not performed~~forbidden just after start of the charge of the capacitors, and the determination is started at the time when charge voltage  $V_c$  of the capacitor unit is at most a predetermined voltage value " $V_d$ ".

2. (Cancelled)

3. (Original) The power supply device according to claim 1,

wherein lower-limit voltage value " $V_b$ " is expressed by

$$V_b = V_c / (2N),$$

where " $V_c$ " is a charge voltage value of the capacitor unit and " $N$ " is series number of the capacitors.

4. (Original) The power supply device according to claim 1,

wherein the determination is started at the time when a charge voltage value of the capacitor unit is at most a predetermined voltage value.

5. (Previously Presented) The power supply device according to claim 1,

wherein the predetermined voltage value " $V_d$ " is expressed by

$$V_d = V_t \times \{ 1 + (N - 1 - M) \times (1 - \text{dev}) / (1 + \text{dev}) \} - \alpha,$$

where " $V_t$ " is a withstand voltage value per capacitor cell, " $\text{dev}$ " is a capacity variation of the capacitors, " $N$ " is series number of capacitors, " $M$ " is the number of series stages including short-failed capacitors, and " $\alpha$ " is a detection error margin.